

Search Notes

Application/Control No.

10/645,682

Examiner

H.Jey Tsai

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2812

SEARCHED

Class	Subclass	Date	Examiner
438	243- 249,386- 392,713	3/11/2005	J

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	243	3/11/2005	J

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR